

Low voltage conductance in small tunnel junctions.

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A discrete charge transfer in a small tunnel junction where Coulomb interactions are important can excite electron-hole pairs near the Fermi level. We use a simple model to study the associated nonequilibrium properties and found two novel effects: (i) for junctions with electrodes of the same electronic properties, a leakage current exists within the Coulomb gap even when the environmental impedance is infinite; (ii) for junctions with electrodes of different electronic properties, the differential conductance diverges when a net interaction between conduction electrons is attractive, and it is strongly suppressed for a net repulsive interaction.

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Small tunnel junctions show unique features associated with a discrete charge transfer across the energy barrier [1]. These systems are being studied in detail, and have striking implications for other fields of physics [2].

In this Letter, we focus on tunneling processes occurring at energies below the elementary charging energy $E_C = e^2/2C$, e and C being the electronic charge and the junction capacitance. This is the energy range within which small tunnel junctions show their most interesting properties, such as Coulomb blockade. Our main results in this regime are:

i) Junctions whose electrodes have the same electronic properties, show a leakage current within the Coulomb gap even when the environmental impedance is infinite. This leakage current smoothes the current-voltage (I-V) characteristics and reduces the Coulomb offset extrapolated back from the high-voltage part of the I-V curve.

ii) In junctions with electrodes of different electronic properties, the I-V characteristics show rectifying features within the Coulomb gap, and under certain circumstances, conductivity diverges at zero voltage, exhibiting a superconducting-like behavior.

While most discussions are restricted to single junctions, this Letter also presents extensions to multijunction arrays.

A distinguishing feature of our analysis is that it takes account of the fact that electron tunneling in small junctions strongly perturbs the electronic states close to the Fermi level. The conventional theory assumes that the junction is in a new equilibrium state immediately after a tunneling event. This implies that the electronic wavefunctions which describe the electrons near the Fermi level are not affected by the change in the charge state of the junction, and only a rigid shift in the energy levels must be considered. The validity of this assumption, in fact, depends on the inhomogeneities in the potential

generated after the charge build-up, over scales comparable to the mean free path of the electrons. When the inhomogeneities cannot be neglected, the dependence of the electronic wavefunctions on the charge state of the junction must be included in the calculations. The importance of this effect increases as the electrodes become smaller.

If the change in the electronic wavefunctions is not negligible, each charge transfer is followed by sizable shake-up processes [3]. The Nozières-Dominicis problem describes, in a similar way, the ejection of a core electron which changes the charge state of an atom within a metal [5]. A substantial shakeup of the conduction electrons follows, leading to singularities in the photoemission and X-ray absorption spectra. As in the junction, the system experiences a fast change –the modification of the charge state– and a resulting slow relaxation. The main alteration in the junction case is that the transferred electron that ‘triggers’ a time-dependent perturbation is itself part of the Fermi liquid. This difference, however, does not qualitatively change the above picture because the final state interaction is caused, not by the tunneling electron itself, but the change in the *collective* coordinate which describes the charge state.

For more precision, we separate the tunneling event into two processes having very different time scales: (i) an electron near the Fermi level in one electrode tunnels to the other, giving rise to a charge build-up, and (ii) low-energy electron-hole pairs are excited in response to this quick change in the potential. This idea can be implemented mathematically by separating the degrees of freedom of the junction into two classes: a collective one, which lumps together all ‘fast’ variables, and the dynamics of the electrons at the Fermi level, which can be described in terms of independent electron-hole pairs. The dynamics of the fast variable are associated with changes in the charge state of the junction. We define this collective variable as Q and its conjugate variable as ϕ such that $[\phi, Q] = ie$, where e is the electronic charge. The wavefunction of the junction can be written as a superposition of states specified by the variable ϕ and the occupancy of the levels around the Fermi energy: $|\phi, \{n_k\}\rangle$. Charge relaxation occurs over energy scales comparable to the plasmon energy, $\sim 1\text{eV}$, while we use the quasiparticle description for processes at energies, or voltages, comparable to the charging energy of the system, $E_C \sim 1 - 10\text{meV}$, so that our distinction is justified.

Including all these effects, the junction can be described by the Hamiltonian [6],

$$\begin{aligned}\mathcal{H} &= \mathcal{H}_C + \mathcal{H}_L + \mathcal{H}_R + \mathcal{H}_T + \mathcal{H}_V \\ \mathcal{H}_C &= \frac{(Q - Q_x)^2}{2C} \\ \mathcal{H}_{R,L} &= \sum_k \epsilon_{k,R,L} c_{k,R,L}^+ c_{k,R,L}\end{aligned}$$

$$\begin{aligned}
\mathcal{H}_T &= \hat{t} e^{i\phi} \sum_{k,k'} c_{k,R}^+ c_{k',L} + h.c. \\
\mathcal{H}_V &= v_R (Q - Q_x) \sum_{k,k'} c_{k,R}^+ c_{k',R} \\
&\quad - v_L (Q - Q_x) \sum_{k,k'} c_{k,L}^+ c_{k',L}
\end{aligned} \tag{1}$$

Here Q_x stands for any offset charge which may exist at equilibrium. The differences between Hamiltonian (1) and more conventional treatments are the separation of slow and fast degrees of freedom, and the introduction of the shakeup processes through the last term [3]. Note that the tunneling hamiltonian $\mathcal{H}_T$ is defined such that modification in the charge state is accompanied by a change in the distribution of quasiparticles at the Fermi level.

We can eliminate the slow degrees of freedom, leaving only the charge. The influence of the electrons on the evolution of the charge can be expressed in terms of electronic propagators [4]. The inclusion of the shake-up processes implies that the propagators have to be computed for the *nonequilibrium* ground state of charged electrodes. We will use only their asymptotic behavior at long times [3]:

$$G^{R,L}(t) = -i \frac{e^{-iE_F t}}{t} (E_C t)^{g_{R,L}} \tag{2}$$

In equation (2), the effects of the potential on the electrons at the Fermi level, due to v_R and v_L , are described by the phase shifts induced at the Fermi level, $\delta_{R,L}$, and $g_{R,L} = 2\delta_{R,L}/\pi - (\delta_{R,L}/\pi)^2$.

The contribution that has the anomalous exponent arises from the shake-up. An effective coupling between tunneling processes separated by time t is described by the product $G^R(t) \times G^L(t)$, which depends on a single parameter, $\bar{g} = -g_R - g_L$. This approach, which is based on the definition of an appropriate tunneling density of states that includes the effects of the interaction, is rather general, and can be applied in many contexts [7].

We now consider the case of a single junction with electrodes of the same electronic properties. After a tunneling event, the potentials acting on the states at the Fermi level are equal in magnitude but opposite in sign, and so are the phase shifts, i.e., $\delta_R = -\delta_L \equiv \delta$. Hence, we find that $\bar{g} = 2(\delta/\pi)^2 > 0$. In the small coupling limit, $t/E_C \ll 1$, the current operator, $e\partial(N_R - N_L)/\partial t$, is

$$\hat{j} = ie\hat{t}e^{i\phi} \sum_{k,k'} c_{k,R}^+ c_{k',L} + h.c. \tag{3}$$

Using Kubo's formula, the conductivity at finite frequencies and zero temperature is given by

$$\sigma(\omega) = \frac{\sum | \langle 0 | \hat{j} | \omega \rangle |^2}{\omega} \tag{4}$$

where the summation is taken over all excited states of energy ω .

The numerator in (4) is the Fourier transform of a correlation function of the type $\langle \hat{j}(t)\hat{j}(t') \rangle$. We now express this correlation function as a series expansion in powers of $\mathcal{H}_T$. Each insertion of this operator generates a kink in the time evolution of the charge. A schematic representation of a given term in this series is shown in Fig. 1.

We can use the standard analogy with a one dimensional system with logarithmic interactions [8]. The contribution of the path shown in Fig. 1 then reduces to the interaction effects between two charge dipoles at separation t . It decays over a long time like $t^{(-4-\bar{g})}$. Taking the Fourier transform, and inserting it in (4), we obtain

$$\begin{aligned} \sigma(\omega) &\sim \frac{e^2}{h} t^4 N_R(E_F)^2 N_L(E_F)^2 \left(\frac{\omega}{E_C} \right)^{2+\bar{g}} \\ &\sim \frac{e^2}{h} \left(\frac{R_Q}{R_T} \right)^2 \left(\frac{\omega}{E_C} \right)^{2+\bar{g}}. \end{aligned} \quad (5)$$

where $N_R(E_F)$ and $N_L(E_F)$ denote the respective density of states at the Fermi level in the right and left electrodes. This formula is valid at low frequencies, $\hbar\omega \ll E_C$.

The existence of a finite conductance at frequencies within the Coulomb gap also implies a finite differential resistance in the same region. Equation (5) is a measure of the probability that the junction absorbs energy in quanta given by $\hbar\omega$. Thus, at low voltages, we expect $I \propto V^{3+\bar{g}}$, as shown in Fig. 2.

Our results imply that a single normal tunnel junction is always dissipative. The decay of the ‘Coulomb blockade state’ cannot be significantly reduced by lowering the temperature or increasing the resistance in the external circuit. We stress that, in an experiment designed to measure the I-V characteristics, this current within the Coulomb gap does not violate the conservation law of energy. To determine the I-V characteristics, the junction has to be attached to a reservoir in which dissipation can take place. Otherwise, even in the absence of Coulomb blockade, electrons at the electrodes cannot be described by Fermi-Dirac distributions. When the circuit is attached to a macroscopic battery, processes which do not change the electrochemical potential difference V across the junction are not forbidden because, as in the Mössbauer effect, the battery instantaneously compensates the work eV . This situation is similar to what we have encountered in the low-impedance environment. In this case, spontaneous fluctuations in the junction charge due to the electromagnetic environment induces tunneling within the Coulomb gap; this process, however, does not violate the conservation law of energy because the battery again compensates the energy necessary for tunneling [9]. In the high-impedance case, however, the second-order process in tunneling is inhibited, and therefore our fourth-order process comes to play a major role.

The same result can be expressed in terms of the fluctuation-dissipation theorem. To make the chemical potentials at the two electrodes unequal, the system has to be brought out of equilibrium. The perturbation required to do so has an intrinsic time scale, given by $\hbar/eV$ (a voltage can be induced by an ac magnetic field, for instance). Processes which have longer relaxation times play no role in the steady state reached by the system. That the absence of these processes give rise to a voltage- or temperature-dependent renormalization of the junction capacitance has been discussed extensively. By the same analysis, these processes can also contribute to the imaginary part of the response function, leading to the dissipation we have shown above.

The existence of a finite subgap conductance will also reduce the Coulomb offset extrapolated back from the high-voltage part of the I-V curve. Most of the current will come from tunneling processes which involve energies between E_C and the applied voltage. They will give rise to a linear dependence of I on V. A current due to the small subgap conductance also contributes, reducing the Coulomb offset. Both the smoothing of the I-V characteristic and the reduction in the Coulomb offset seem to be in agreement with experimental observations [10–12]. Finally, dissipation will be accompanied by heating effects [13].

The analysis presented here can be readily extended to many junction arrays. The frequency (or voltage) dependence of the conductivity is not changed because it is simply related to the interaction between two charge dipoles in a manner similar to that depicted in Fig. 1. The prefactor, on the other hand, has to be replaced by $(h/e^2 R)^N$. This term increases exponentially with the number of junctions for high resistance junction arrays. It will compete with other processes already discussed in the literature, like macroscopic quantum tunneling of charge [14–16]. Physically, the latter implies two coherent tunneling events at two different junctions, and is drastically different from the shakeup we discuss here. It seems an interesting question to separate these two sources of subgap conductance. From the requirement of coherence, we conclude that macroscopic tunneling of charge should be very sensitive to changes in the conductance of a single junction. Shakeup processes, on the other hand, should always be present, independently of the ratio between the different conductances.

We next consider junctions with electrodes of different electronic properties for which $\delta_R \neq \delta_L$. We concentrate on the high conductance limit, $\alpha = h/e^2 R \gg 1$. In this case, it is convenient to start with the effective action:

$$S_{eff} = \sum_{\pm} \alpha_{\pm} \tau_c^{\pm(g_R+g_L)} \int_0^{\beta} d\tau \int_0^{\beta} d\tau' \frac{1 - e^{\pm i[\phi(\tau) - \phi(\tau')]} }{(\tau - \tau')^{2 \pm (g_R + g_L)}} + 2\pi i \frac{Q_x}{e} \quad (6)$$

where the parameter τ_c is the cutoff which is initially set equal to the charging energy. Since the two possible elec-

tron jumps between the electrodes are described by different propagators, they are associated with the two sign choices in the action. The first term is complex, indicating an instability of the ‘neutral’ junction. A real partition function is recovered by assuming a temperature-dependent offset charge Q_x at the electrodes. We have defined two different conductances, $\alpha_{\pm}$. At high voltages or temperatures, we have $\alpha_+ = \alpha_- = \alpha_0$, where $\alpha_0 = h/(e^2 R)$.

The high frequency modes in the phase can be integrated out in (6), leading to the scaling equations [17]

$$\begin{aligned}\frac{\partial \alpha_{\pm}}{\partial \ln(eV)} &= \pm \alpha_{\pm} + \frac{2}{\pi^2} \\ \frac{\partial Q_x}{\partial \ln(eV)} &= -\alpha_- (g_R + g_L)\end{aligned}\quad (7)$$

Here, the second equation is needed to keep the partition function real at all scales. The first equation is obtained by scaling separately the contributions from the two types of hopping processes.

These equations have a nontrivial fixed point at $\alpha_{\text{crit}} = 2/(\pi^2 |g_R + g_L|)$. For initial conductances above this value, the conductances within the Coulomb gap scale towards infinity as the scale of frequencies (or voltages) is reduced. Below this threshold, we recover the scaling equations for symmetric tunnel junctions already known [4]. Integrating (7), we obtain

$$\begin{aligned}\alpha_{\pm}(V) &= \alpha_0 \left(\frac{eV}{E_C} \right)^{\pm(g_R + g_L)} & \alpha_0 \gg \alpha_{\text{crit}} \\ \alpha_{\pm}(V) &= \alpha_0 - \frac{2}{\pi^2} \log \left(\frac{E_C}{eV} \right) & \alpha_0 \ll \alpha_{\text{crit}}\end{aligned}\quad (8)$$

The first of these equations leads to asymmetric I-V characteristics. The differential resistance at zero vanishes for the positive sign and diverges for the negative sign. The qualitative features of the I-V characteristics in the two cases are shown in Fig. 3.

The scaling equations (7) are valid in the limit of high conductances. This condition is always satisfied when the frequency (or voltage) is scaled towards lower values in the high-conductance side of the I-V characteristics. This effective ‘normal-state superconductivity’ is a novel effect which merits further theoretical and experimental study.

The range of parameters required for its observation can be inferred from the previous analysis. The difference in phase shifts between the two electrodes must be large. This implies that they must be very different, and that the potentials induced by their respective charge distributions must be local in space. A negative phase shift indicates that an additional charge pulls states below the Fermi level, while a positive shift has the opposite effect. One of the electrodes should therefore show a net repulsion between charges, while the other should have a net attraction. Similarly, it can be shown that a divergent conductivity arises from tunneling between two attractive Luttinger liquids [7]. Finally, the normal state

conductance, α_0 , has to be large, meaning good contact between the electrodes, or many channels through which electrons can tunnel. The latter possibility, however, will tend to reduce the phase shifts by spreading the potential of a unit charge over the different channels. We therefore think that this effect would be better observed in small tunnel junctions with good connections.

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FIG. 1. Path integral formulation of the calculation of the $\langle \hat{j}(t')\hat{j}(t) \rangle$ correlation function (see text).

FIG. 2. I-V characteristics of a normal, symmetric tunnel junction.

FIG. 3. I-V characteristics of an asymmetric tunnel junction, where $V_c = E_C/e \exp(-\pi^2(\alpha_0-1)/2)$ is the renormalized offset voltage. Solid line: $\alpha_0 \ll \alpha_{\text{crit}}$. Broken line: $\alpha_0 \gg \alpha_{\text{crit}}$.